


<b>Search Notes</b> 	<b>Application/Control No.</b> 10810964	<b>Applicant(s)/Patent Under Reexamination</b> DEY ET AL.
	<b>Examiner</b> CHAU NGUYEN	<b>Art Unit</b> 2176

### SEARCHED

Class	Subclass	Date	Examiner
715	200	06/11/2008	cn
	201	06/11/2008	cn
	205	06/11/2008	cn
	206	06/11/2008	cn
	243	06/11/2008	cn
	246	06/11/2008	cn
	247	06/11/2008	cn
	254	06/11/2008	cn
	267	06/11/2008	cn
	201	10/18/2009	cn
715	202	10/18/2009	cn
	205	10/18/2009	cn
	206	10/18/2009	cn
707	4	10/18/2009	cn
	6	10/18/2009	cn

### SEARCH NOTES

Search Notes	Date	Examiner
Updated Search on East Reports	06/09/2008	cn
	06/10/2008	cn
	06/11/2008	cn
Inventor Search for Double Patenting	06/10/2008	cn
Updated Search on East Reports	11/18/2008	cn
	11/19/2008	cn
Updated Search on East Reports	05/24/2009	cn
Updated Search on East Reports	08/17/2009	cn
	08/26/2009	cn
	08/27/2009	cn
Updated Search On East Reports	11/17/2009	cn
	11/18/2009	cn
NPL search on Google Search Engine	11/18/2009	cn
Interference Search	11/18/2009	cn

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**INTERFERENCE SEARCH**

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
715	201	11/18/2009	cn
	202	11/18/2009	cn
	205	11/18/2009	cn
	206	11/18/2009	cn
707	4	11/18/2009	cn
	6	11/18/2009	cn

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